


<b>Search Notes</b> 	<b>Application/Control No.</b> 10813818	<b>Applicant(s)/Patent Under Reexamination</b> WANG ET AL.
	<b>Examiner</b> Hung, Yubin	<b>Art Unit</b> 2624

SEARCHED			
Class	Subclass	Date	Examiner
382	173, 176	12/26/07	YH
707	2-4, 104.1	12/26/07	YH
715	501.1, 513	12/26/07	YH

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST text search (USPGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)	12/26/07	YH	
Inventor and assignee search	12/21/07	YH	
ACM	12/21/07	YH	
IEEE Xplore	12/21/07	YH	
SPIE	12/21/07	YH	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner